

IN THE UNITED STATES PATENT AND TRADEMAR (19) FFICE

C 170"

In re PATENT APPLICATION of

Kyoung-Yoon Baek et al.

Group Art Unit: 1756

Serial No.: 10/043,329

Examiner: Young, Christopher G.

Filed: 14 January 2002

For: OVERLAY KEY, METHOD OF MANUFACTURING THE SAME AND METHOD OF MEASURING AN OVERLAY DEGREE USING THE SAME

RESPONSE TO ELECTION/RESTRICTION REQUIREMENT

U.S. Patent and Trademark Office 2011 South Clark Place Customer Window Crystal Plaza Two, Lobby, Room 1B03 Arlington, VA 22202

Sir:

In response to the Office Action of 25 July 2003, Applicants elect the invention of Group I, Claims 1-48, drawn to an overlay key and method of making the same. The election is without traverse.

Respectfully submitted,

VOLENTINE FRANCOS, PLLC

Date: 22 August 2003

Kenneth D. Springer Registration No. 39,843

12200 Sunrise Valley Drive, Suite 150

Reston, Virginia 20191

Telephone No.: (703) 715-0870 Facsimile No.: (703) 715-0877